Sheet 1 of ATTY. DOCKET NO. Divisional of SERIAL NO. **FORM PTO-1449** U.S. DEPARTMENT OF COMMERCE 09/504,718, PATENT AND TRADEMARK OFFICE 100725-00068 APPLICANT LIST OF REFERENCES CITED BY APPLICANT MORI et al. FILING DATE GROUP (Use several sheets if necessary) 3682 January 8, 2002 **U.S. PATENT DOCUMENTS** SUB-**FILING EXAMINER DOCUMENT** DATE **CLASS CLASS** DATE NAME INITIAL NO. ( 5,941,646 AΑ 08/1999 MORI et al. AΒ 5,932,946 08/1999 MIYASAKA et al. 5,810,481 09/1998 NII et al. AC 5,762,423 06/1998 MORI et al. ΑD 5,762,895 06/1998 SCHWETZ et al. ΑE ΑF 5,628,569 05/1997 HAYAKAWA et al. **FOREIGN PATENT DOCUMENTS** TRANSLATION YES NO PART. SUB-DOCUMENT DATE COUNTRY **CLASS CLASS** NO. AG DE 198 09 770 A1 09/10/98 **GERMANY** OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

OTHER REPORTS (mondaing reacher, tries, Bates, Forthfolia, Gages, Etc.)			
£	АН	Abstract of Japanese Patent Publication No. 05071539; dated March 23, 1993	
$\alpha$	Al	Abstract of Japanese Patent Publication No. 11264031; dated September 28, 1999	
$\mathcal{L}$	AJ	Abstract of Japanese Patent Publication No. 11037156; dated February 9, 1999	
0	AK	Abstract of Japanese Patent Publication No. 11236604; dated August 31, 1999	
EC	AL	Abstract of Japanese Patent Publication No. 62080310; dated April 13, 1987	
$\mathcal{C}$	АМ	Abstract of Japanese Patent Publication No. 06207619; dated July 26, 1994	
50	AN	Abstract of Japanese Patent Publication No. 01242821; dated September 27, 1989	
EC	AO	Abstract of Japanese Patent Publication No. 11062969; dated March 5, 1999	
EC	AP	Abstract of Japanese Patent Publication No. 02008302; dated January 11, 1990	

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